

**Search Notes**

Application/Control No.

10/742,919

Examiner

Tai Duong

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

2871

**SEARCHED**

Class	Subclass	Date	Examiner
349	110, 111	2/8/2007	TD
	141, 153		
	156, 190		
430	5, 6		
	7, 20		
	321		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US PGPUB; USPAT; EPO; JPO; DERWENT; IBM TDB) see search history printout	2/8/2007	TD